

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/811,074	PAN, FENG	
Examiner	Art Unit	
Joffroy S. Zwoizia	2816	

SEARCHED					
Class	Subclass	Date	Examiner		
327	530	4/13/2005	JZ		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		